

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/665,444	SAWICKI ET AL.	
Examiner	Art Unit	
Ouga A Tran	2176	

	SEAR	CHED	
Class	Subclass	Date	Examiner
715	513	2/15/2006	
715	500	2/15/2006	1
345	853	2/15/2006	<i>X</i>
345	740	2/15/2006	3)/
345	581	7/20/2006	1

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	1				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB (see search history printout)	2/15/2006	8		
IACM DataBase (see search history printout)	2/15/2006 -	8		
USPAT, US-PGPUB, (see search history printout)	2/17/2006			
EAST (UAPAT, USPGPUB OCR EPO JPO DERWENT IBM_TOB) See Search History Printouit	7/1/2006	8		